



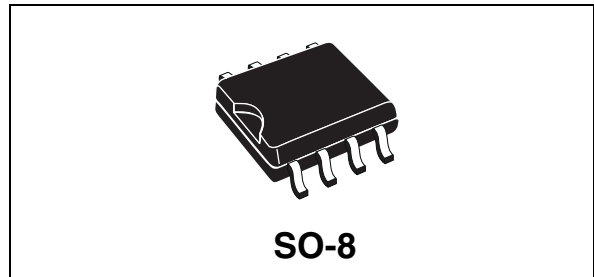
VNS3NV04D-E

OMNIFET II fully autoprotected Power MOSFET

Features

Max On-State resistance (per ch.)	R_{ON}	120m Ω
Current limitation (typ)	I_{LIMH}	3.5A
Drain-Source clamp voltage	V_{CLAMP}	40V

- Linear current limitation
- Thermal shut down
- Short circuit protection
- Integrated clamp
- Low current drawn from input pin
- Diagnostic feedback through input pin
- Esd protection
- Direct access to the gate of the power mosfet (analog driving)
- Compatible with standard power mosfet



Description

The VNS3NV04D-E is a device formed by two monolithic OMNIFET II chips housed in a standard SO-8 package. The OMNIFET II are designed in STMicroelectronics VIPower M0-3 Technology: they are intended for replacement of standard Power MOSFETs from DC up to 50KHz applications. Built in thermal shutdown, linear current limitation and overvoltage clamp protects the chip in harsh environments.

Fault feedback can be detected by monitoring the voltage at the input pin.

Table 1. Device summary

Package	Order codes	
	Tube	Tape and Reel
SO-8	VNS3NV04D-E	VNS3NV04DTR-E

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1 Block diagram and pin description

Figure 1. Block diagram

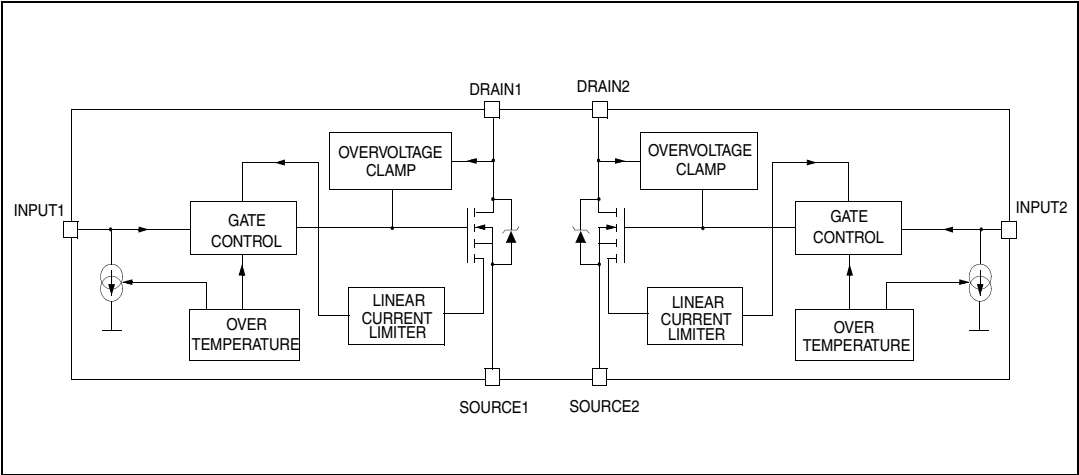
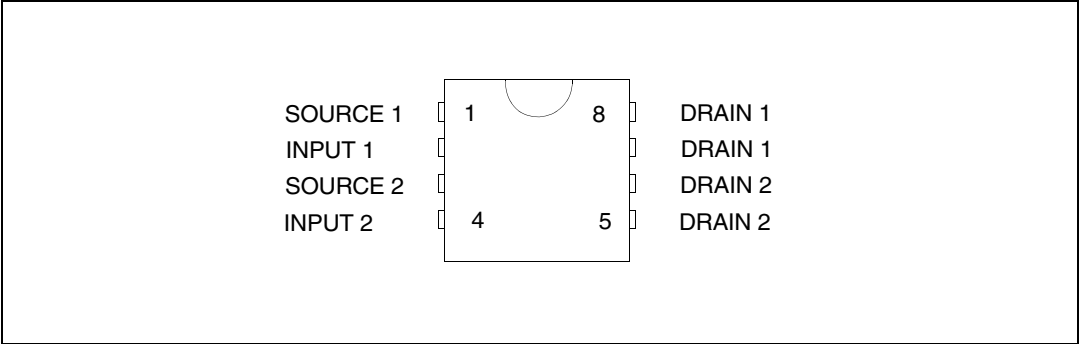
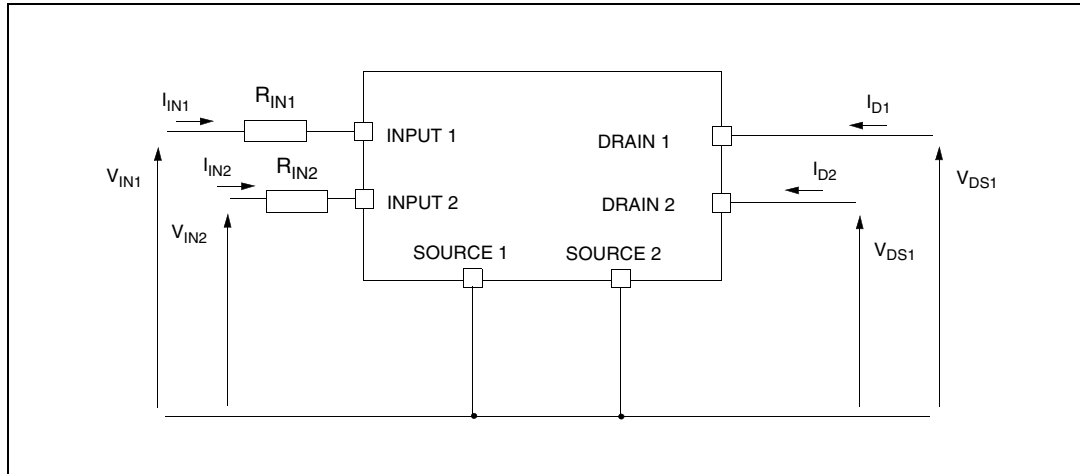


Figure 2. Configuration diagram (top view)



2 Electrical specifications

Figure 3. Current and voltage conventions



2.1 Absolute maximum ratings

Stressing the device above the rating listed in the “Absolute maximum ratings” table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to Absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE program and other relevant quality document.

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DSn}	Drain-Source Voltage ($V_{INn}=0V$)	Internally clamped	V
V_{INn}	Input voltage	Internally clamped	V
I_{INn}	Input current	+/-20	mA
$R_{IN\ MINn}$	Minimum input series impedance	220	Ω
I_{Dn}	Drain current	Internally limited	A
I_{Rn}	Reverse DC output current	-5.5	A
V_{ESD1}	Electrostatic discharge ($R=1.5K\Omega$, $C=100pF$)	4000	V
V_{ESD2}	Electrostatic discharge on output pins only ($R=330\Omega$, $C=150pF$)	16500	V
P_{tot}	Total dissipation at $T_c=25^\circ C$	4	Ω
T_j	Operating junction temperature	Internally limited	$^\circ C$
T_c	Case operating temperature	Internally limited	$^\circ C$
T_{stg}	Storage temperature	-55 to 150	$^\circ C$

2.2 Thermal data

Table 3. Thermal data

Symbol	Parameter	Max value	Unit
$R_{thj-lead}$	Thermal resistance junction-lead (per channel)	30	°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient	80 ⁽¹⁾	°C/W

1. When mounted on a standard single-sided FR4 board with 50mm² of Cu (at least 35 µm thick) connected to all DRAIN pins of the relative channel

2.3 Electrical characteristics

Values specified in this section are for -40°C < T_j < 150°C, unless otherwise stated.

Table 4. Off

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
V_{CLAMP}	Drain-Source clamp voltage	$V_{IN}=0V$; $I_D=1.5A$	40	45	55	V
V_{CLTH}	Drain-Source clamp threshold voltage	$V_{IN}=0V$; $I_D=2mA$	36			V
V_{INTH}	Input threshold voltage	$V_{DS}=V_{IN}$; $I_D=1mA$	0.5		2.5	V
I_{ISS}	Supply current from input pin	$V_{DS}=0V$; $V_{IN}=5V$		100	150	µA
V_{INCL}	Input-Source clamp voltage	$I_{IN}=1mA$ $I_{IN}=-1mA$	6 -1.0	6.8	8 -0.3	V
I_{DSS}	Zero input voltage drain current ($V_{IN}=0V$)	$V_{DS}=13V$; $V_{IN}=0V$; T _j =25°C $V_{DS}=25V$; $V_{IN}=0V$			30 75	µA

Table 5. On

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$R_{DS(on)}$	Static Drain-Source On resistance	$V_{IN}=5V$; $I_D=1.5A$; T _j =25°C $V_{IN}=5V$; $I_D=1.5A$			120 240	mΩ

Electrical characteristics (continued) ($T_J=25^\circ\text{C}$, unless otherwise specified)**Table 6. Dynamic**

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$g_{fs}^{(1)}$	Forward transconductance	$V_{DD}=13\text{V}$; $I_D=1.5\text{A}$		5.0		S
C_{OSS}	Output capacitance	$V_{DS}=13\text{V}$; $f=1\text{MHz}$; $V_{IN}=0\text{V}$		150		pF

Table 7. Switching

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD}=15\text{V}$; $I_D=1.5\text{A}$ $V_{gen}=5\text{V}$; $R_{gen}=R_{IN\text{ MIN}}=220\Omega$ (see Figure 4)		90	300	ns
t_r	Rise Time			250	750	ns
$t_{d(off)}$	Turn-off delay time			450	1350	ns
t_f	Fall time			250	750	ns
$t_{d(on)}$	Turn-on delay time	$V_{DD}=15\text{V}$; $I_D=1.5\text{A}$ $V_{gen}=5\text{V}$; $R_{gen}=2.2\text{ K}\Omega$ (see Figure 4)		0.45	1.35	μs
t_r	Rise time			2.5	7.5	μs
$t_{d(off)}$	Turn-off delay time			3.3	10.0	μs
t_f	Fall time			2.0	6.0	μs
$(di/dt)_{on}$	Turn-on current slope	$V_{DD}=15\text{V}$; $I_D=1.5\text{A}$ $V_{gen}=5\text{V}$; $R_{gen}=R_{IN\text{ MIN}}=220\Omega$		4.7		A/ μs
Q_i	Total input charge	$V_{DD}=12\text{V}$; $I_D=1.5\text{A}$; $V_{IN}=5\text{V}$ $I_{gen}=2.13\text{mA}$ (see Figure 7)		8.5		nC

Table 8. Source Drain diode

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{SD}^{(1)}$	Forward On voltage	$I_{SD}=1.5\text{A}$; $V_{IN}=0\text{V}$		0.8		V
t_{rr}	Reverse recovery time	$I_{SD}=1.5\text{A}$; $di/dt=12\text{A}/\mu\text{s}$ $V_{DD}=30\text{V}$; $L=200\mu\text{H}$ (see Figure 5)		107		ns
Q_{rr}	Reverse recovery charge			37		μC
I_{RRM}	Reverse recovery current			0.7		A

1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5%

Table 9. Protections ($-40^{\circ}\text{C} < T_j < 150^{\circ}\text{C}$, unless otherwise specified)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I_{lim}	Drain current limit	$V_{IN}=5\text{V}; V_{DS}=13\text{V}$	3.5	5	7	A
t_{dlim}	Step response current limit	$V_{IN}=5\text{V}; V_{DS}=13\text{V}$		10		μs
T_{jsh}	Overtemperature shutdown		150	175	200	$^{\circ}\text{C}$
T_{jrs}	Overtemperature reset		135			$^{\circ}\text{C}$
I_{gf}	Fault sink current	$V_{IN}=5\text{V}; V_{DS}=13\text{V}; T_j=T_{jsh}$	10	15	20	mA
E_{as}	Single pulse avalanche energy	Starting $T_j=25^{\circ}\text{C}$; $V_{DD}=24\text{V}$ $V_{IN}=5\text{V}$ $R_{gen}=R_{IN}$ MIN=220 Ω ; $L=24\text{mH}$ (see Figure 6 and Figure 8)	100			mJ

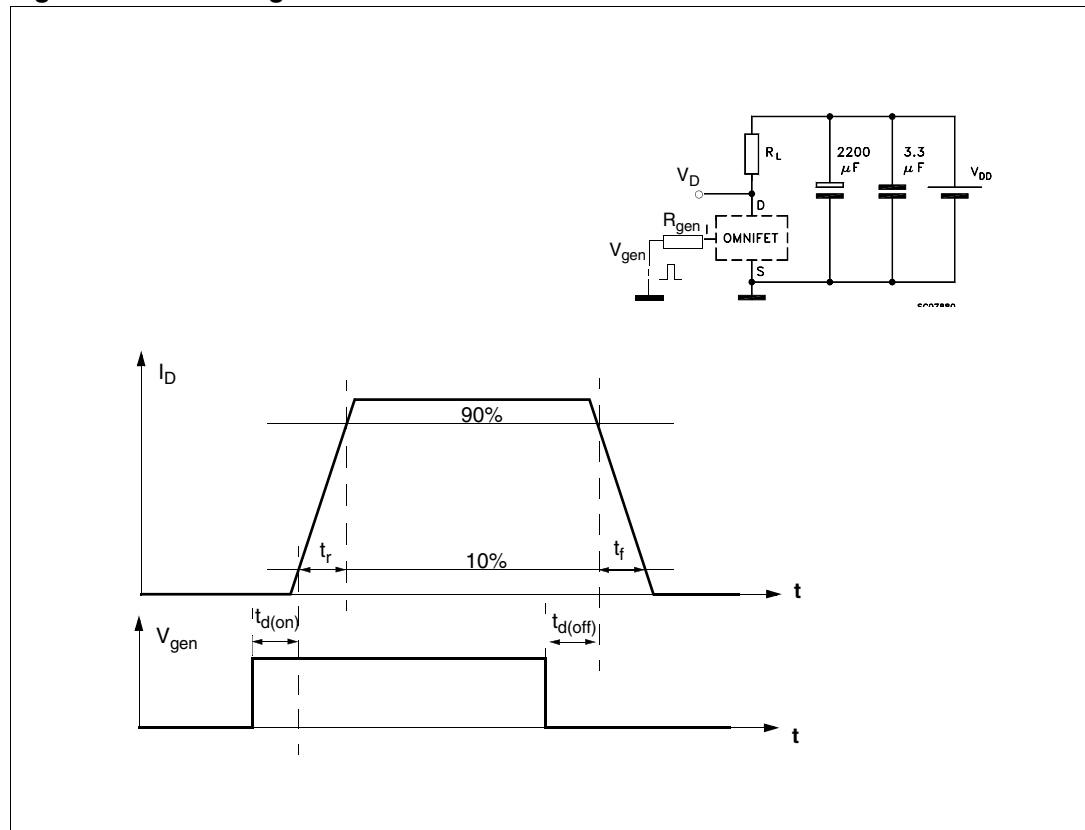
Figure 4. Switching time test circuit for resistive load

Figure 5. Test circuit for diode recovery times

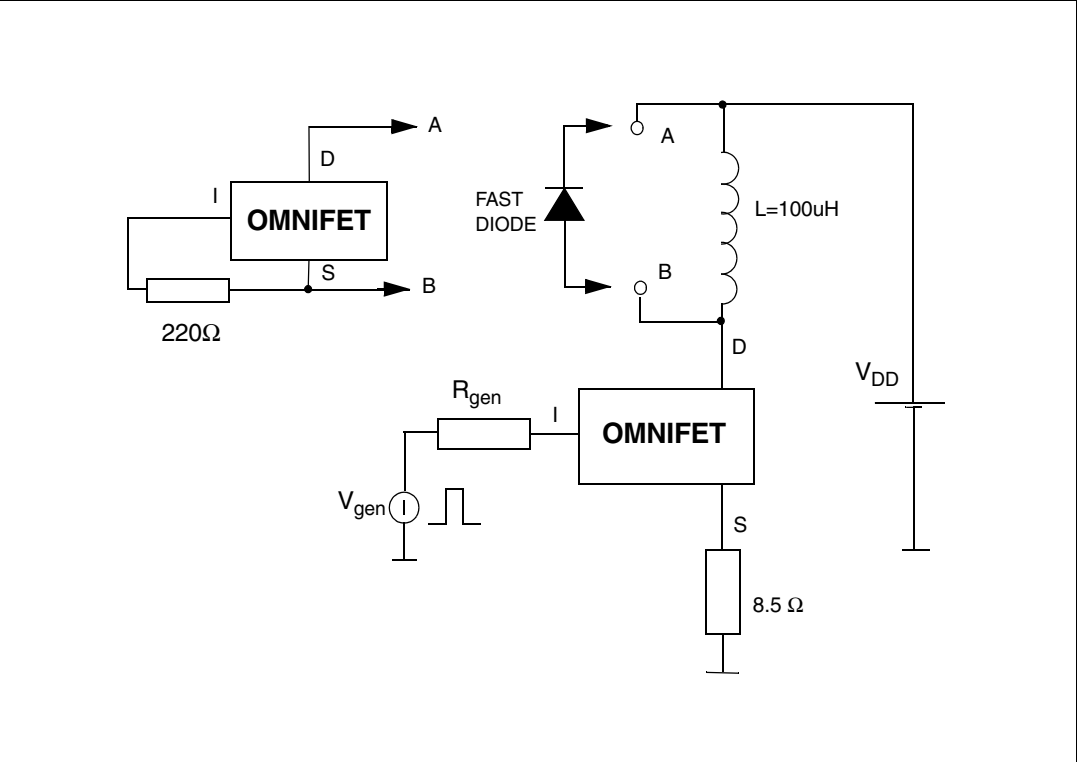


Figure 6. Unclamped inductive load test circuits

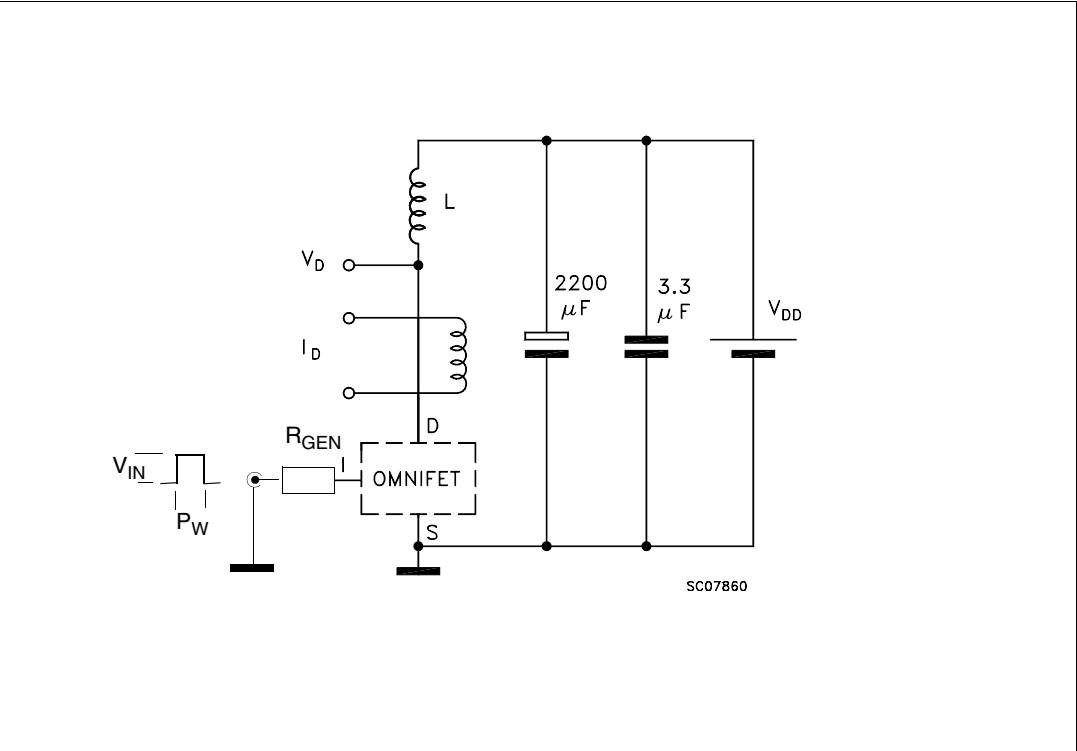


Figure 7. Input charge test circuit

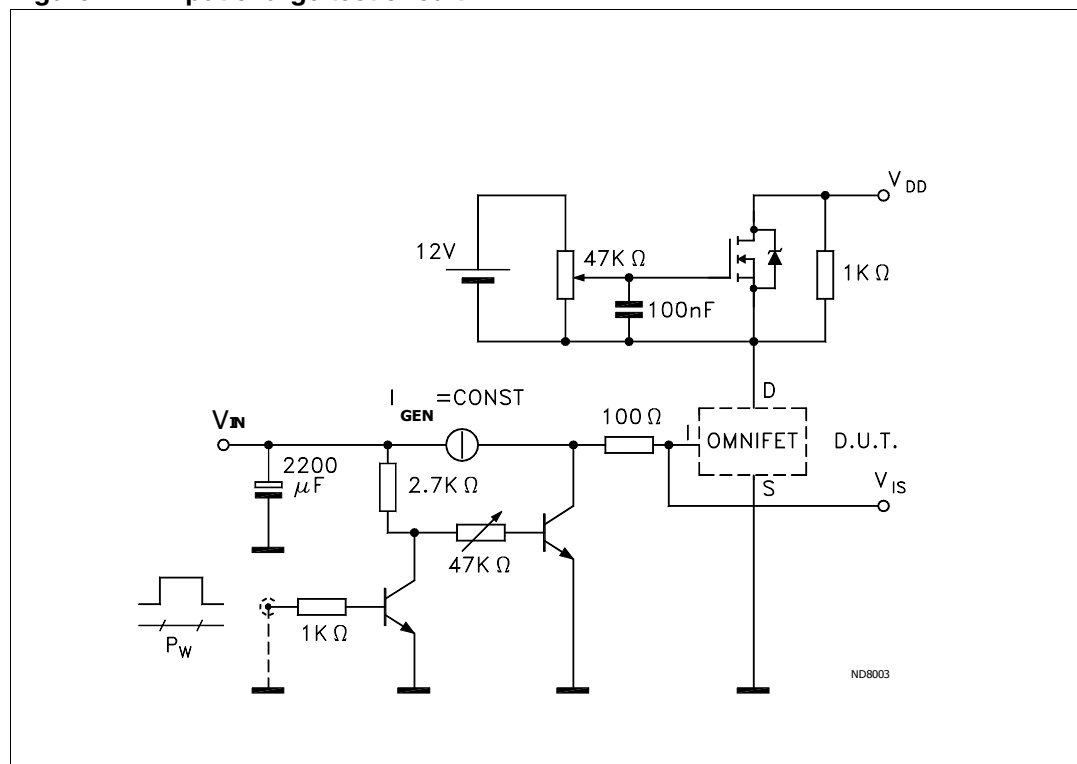
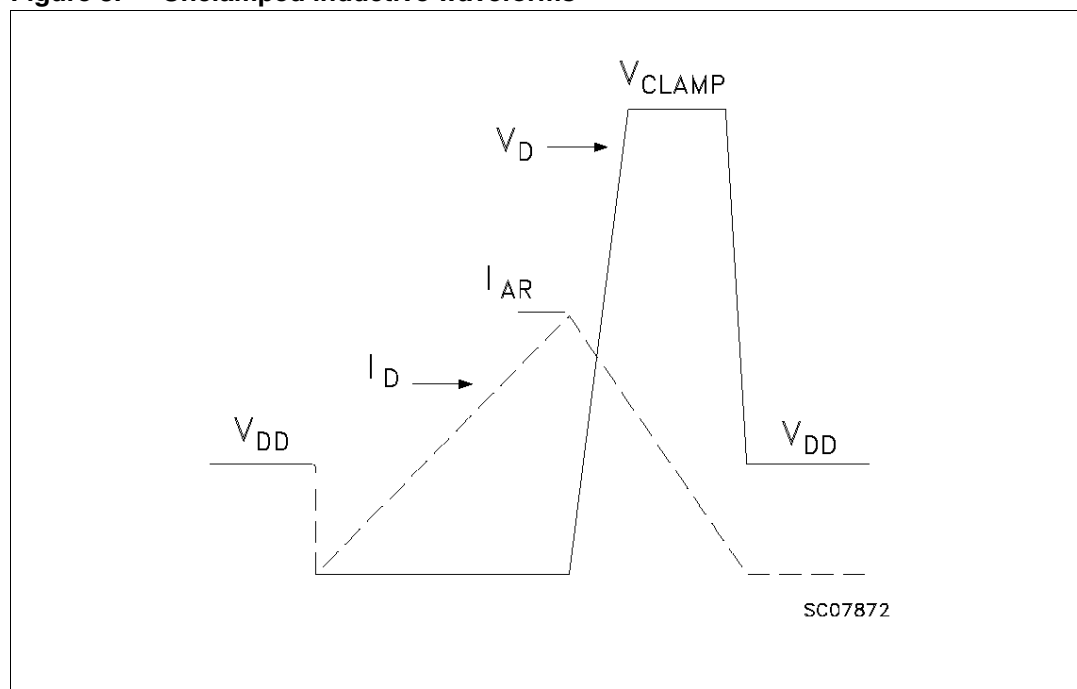


Figure 8. Unclamped inductive waveforms



2.4 Electrical characteristics curves

Figure 9. Source-Drain diode forward characteristics

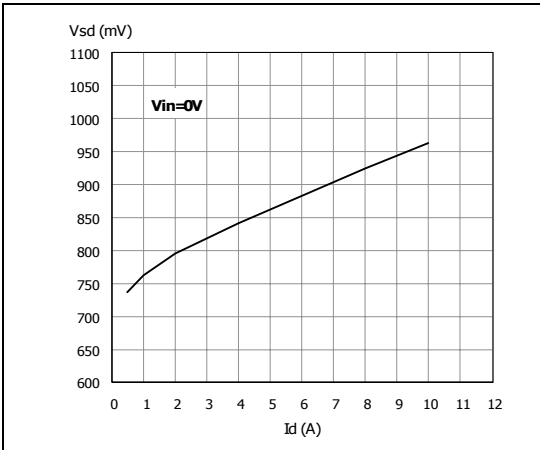


Figure 10. Static Drain-Source On resistance

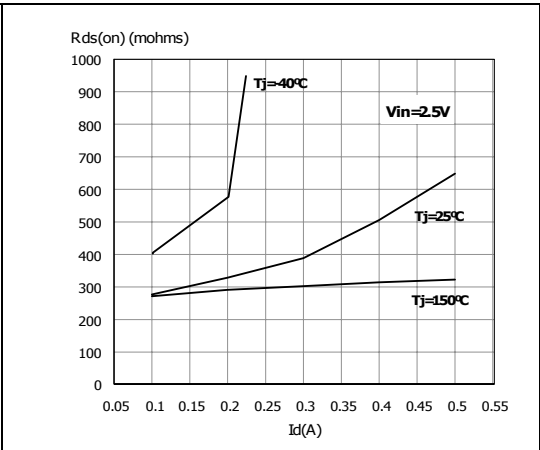


Figure 11. Derating curve

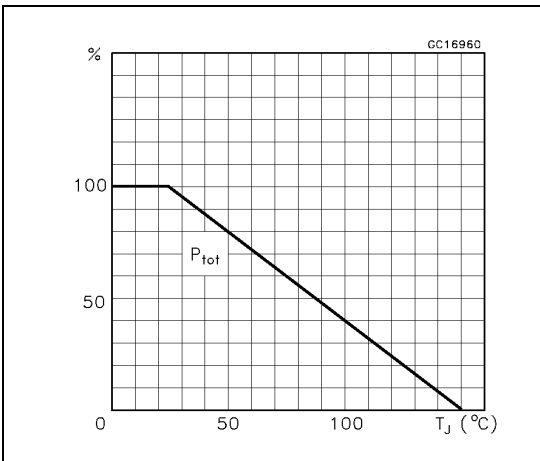


Figure 12. Static Drain-Source On resistance vs. Input voltage

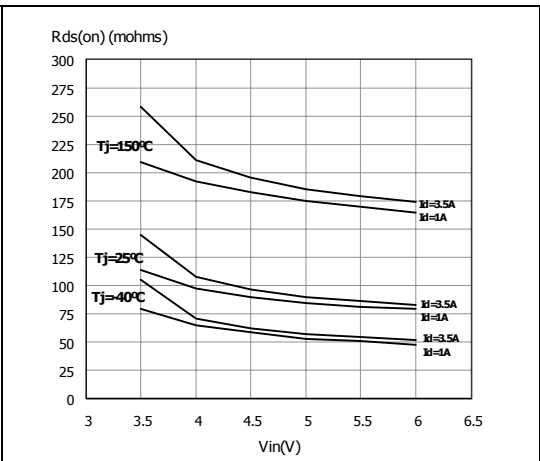


Figure 13. Static Drain-Source On resistance Vs. Input voltage

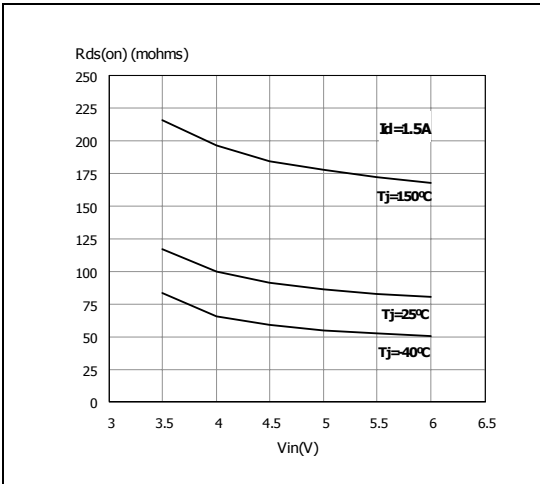


Figure 14. Transconductance

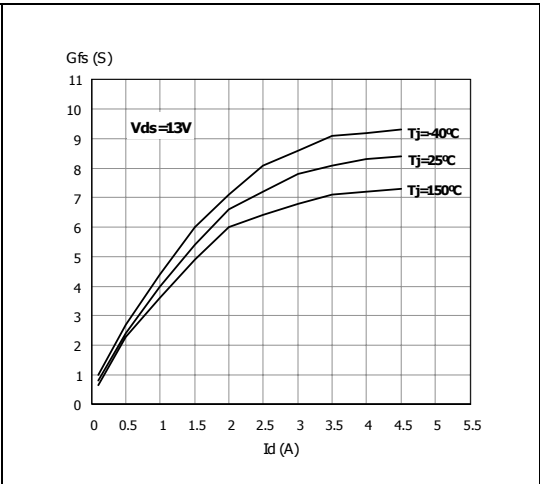


Figure 15. Static Drain-Source On resistance Vs. Id

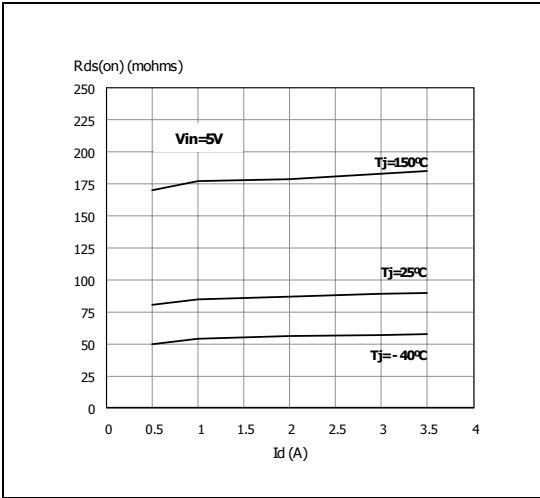


Figure 16. Transfer characteristics

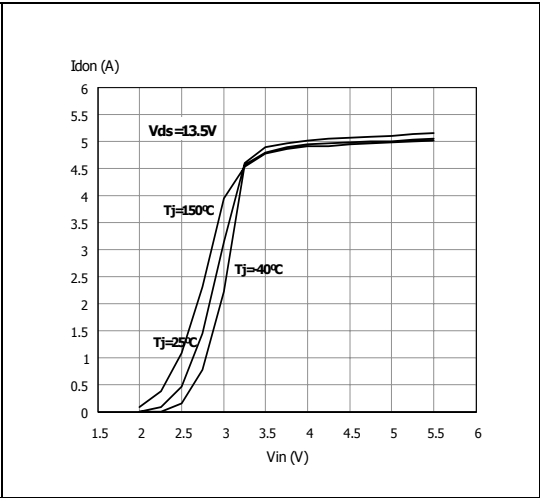


Figure 17. Turn On current slope

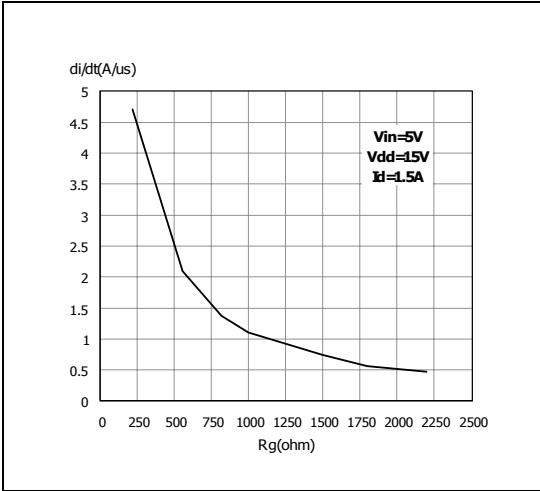


Figure 18. Turn On current slope

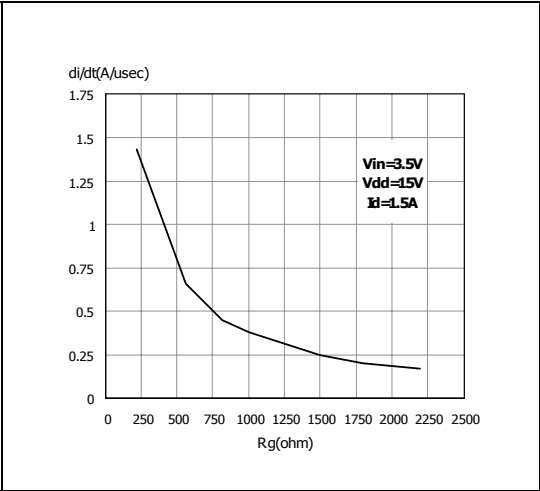


Figure 19. Input voltage Vs. Input charge

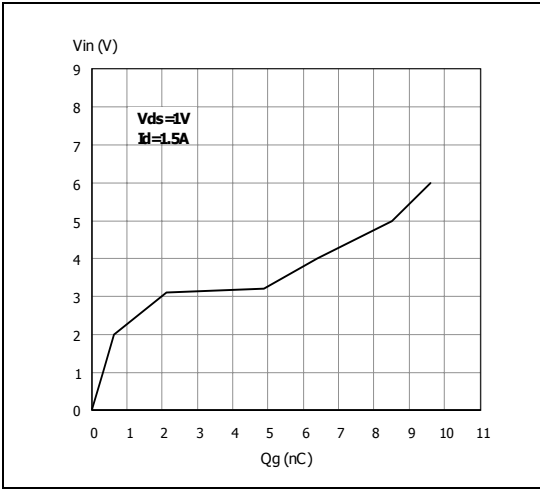


Figure 20. Turn off Drain source voltage slope

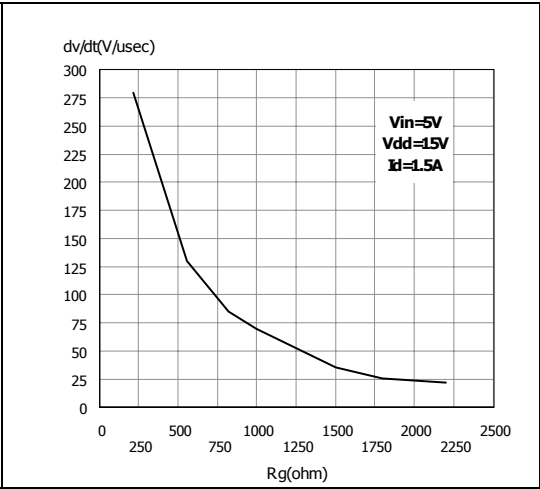


Figure 21. Turn off Drain-Source voltage slope

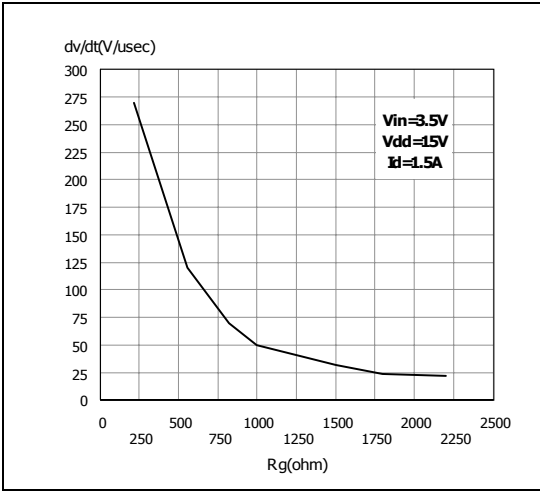


Figure 22. Capacitance variations

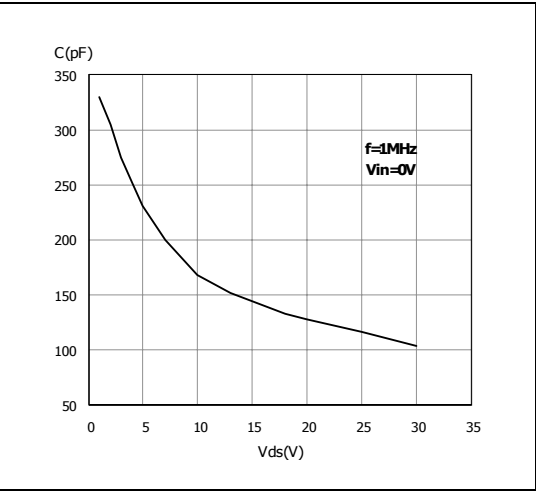


Figure 23. Switching time resistive load

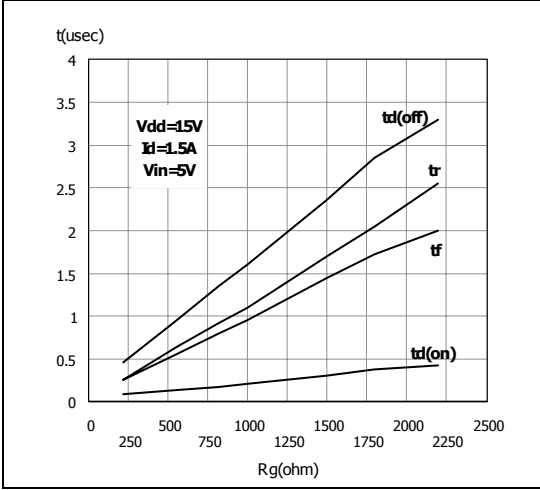


Figure 24. Switching time resistive load

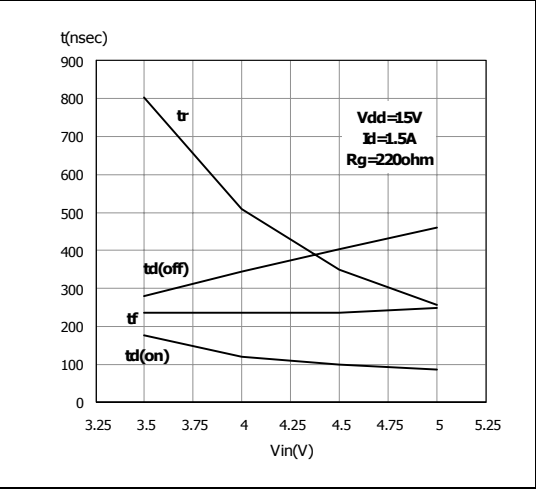


Figure 25. Output characteristics

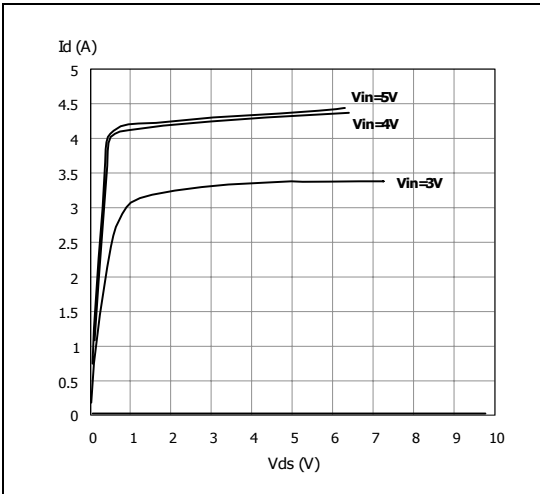


Figure 26. Normalized On resistance Vs. temperature

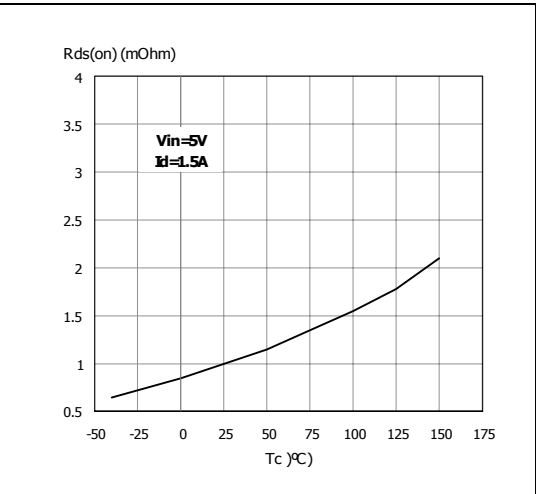


Figure 27. Normalized Input threshold voltage Vs. temperature

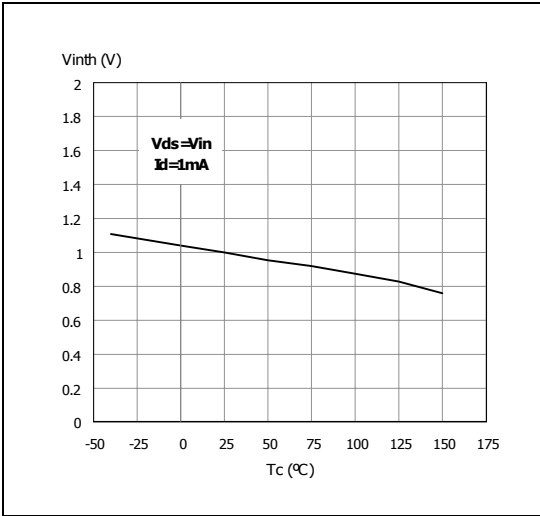


Figure 28. Normalized current limit Vs. junction temperature

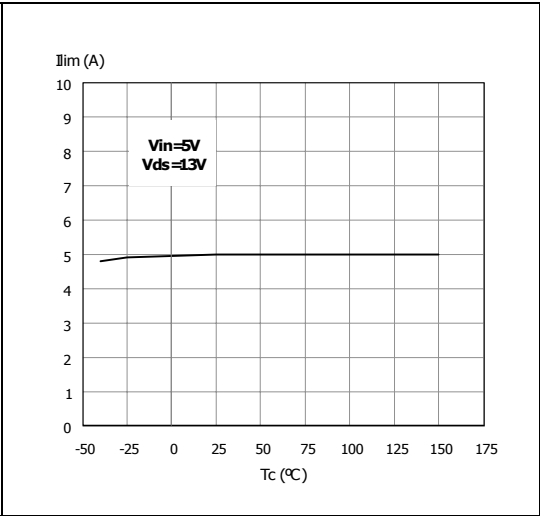
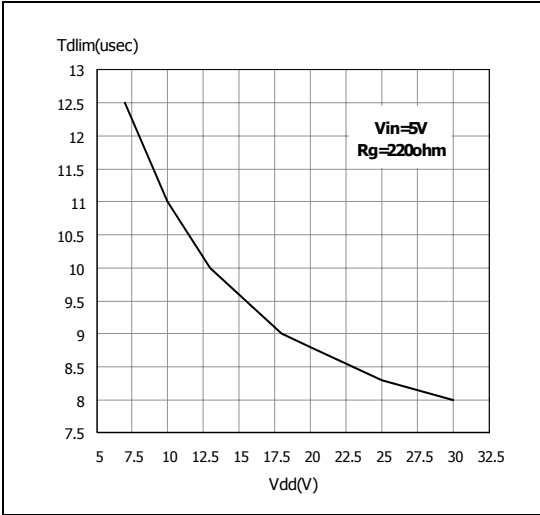


Figure 29. Step response current limit



3 Protection features

During normal operation, the INPUT pin is electrically connected to the gate of the internal power MOSFET through a low impedance path.

The device then behaves like a standard power MOSFET and can be used as a switch from DC up to 50KHz. The only difference from the user's standpoint is that a small DC current I_{SS} (typ. 100 μ A) flows into the INPUT pin in order to supply the internal circuitry.

The device integrates:

3.1 Overvoltage clamp protection

Internally set at 45V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.

3.2 Linear current limiter circuit

Limits the drain current I_D to I_{lim} whatever the INPUT pin voltages. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the overtemperature threshold T_{jsh} .

3.3 Overtemperature and short circuit protection

These are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Overtemperature cutout occurs in the range 150 to 190 °C, a typical value being 170 °C. The device is automatically restarted when the chip temperature falls of about 15°C below shut-down temperature.

3.4 Status feedback

In the case of an overtemperature fault condition ($T_j > T_{jsh}$), the device tries to sink a diagnostic current I_{gf} through the INPUT pin in order to indicate fault condition. If driven from a low impedance source, this current may be used in order to warn the control circuit of a device shutdown. If the drive impedance is high enough so that the INPUT pin driver is not able to supply the current I_{gf} , the INPUT pin will fall to 0V. **This will not however affect the device operation: no requirement is put on the current capability of the INPUT pin driver except to be able to supply the normal operation drive current I_{SS} .**

Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL Logic circuit.

4 Package and packing information

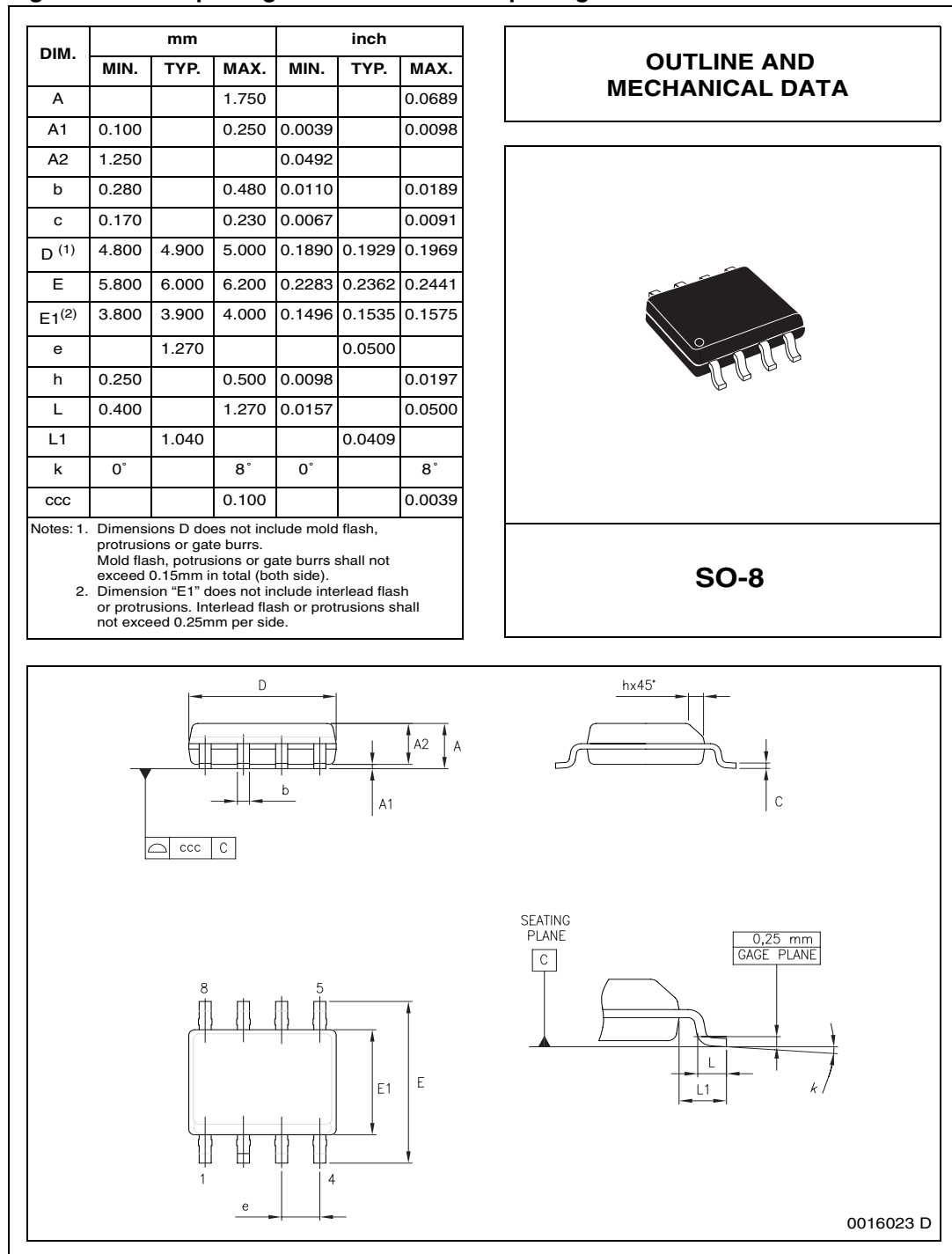
4.1 ECOPACK® packages

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second-level interconnect. The category of Second-Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.

ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com.

4.2 SO-8 Package mechanical data

Figure 30. SO-8 package mechanical data & package outline



4.3 SO-8 Packing information

Figure 31. SO-8 tube shipment (no suffix)

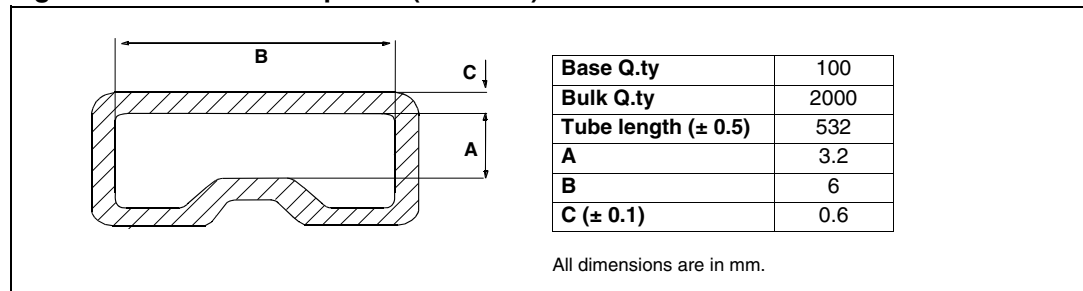
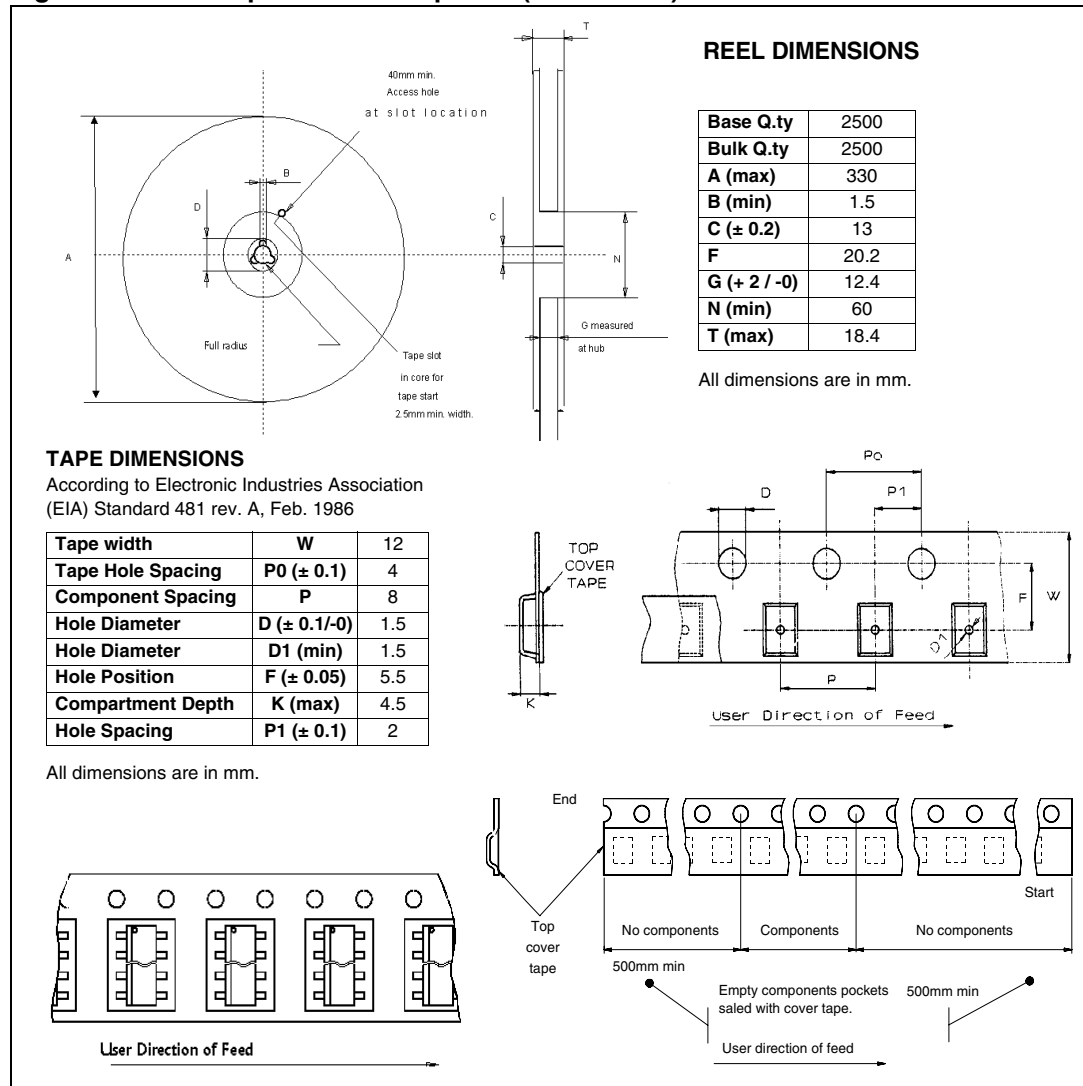


Figure 32. SO-8 tape and reel shipment (suffix "TR")



5 Revision history

Table 10. Document revision history

Date	Revision	Changes
28-Oct-2005	1	Initial release.
02-Jul-2007	2	Document reformatted and converted into new ST template. Table 4: Off - I _{DSS} unit corrected

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